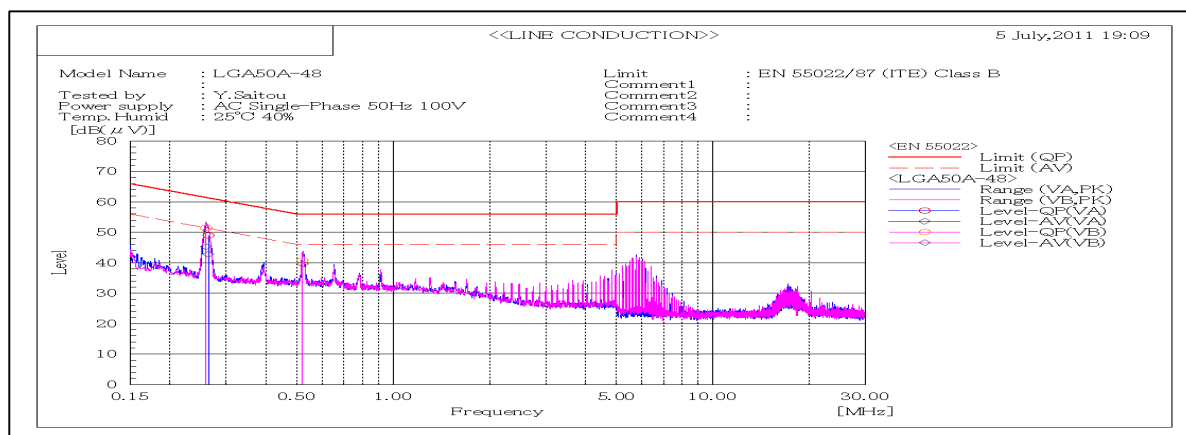
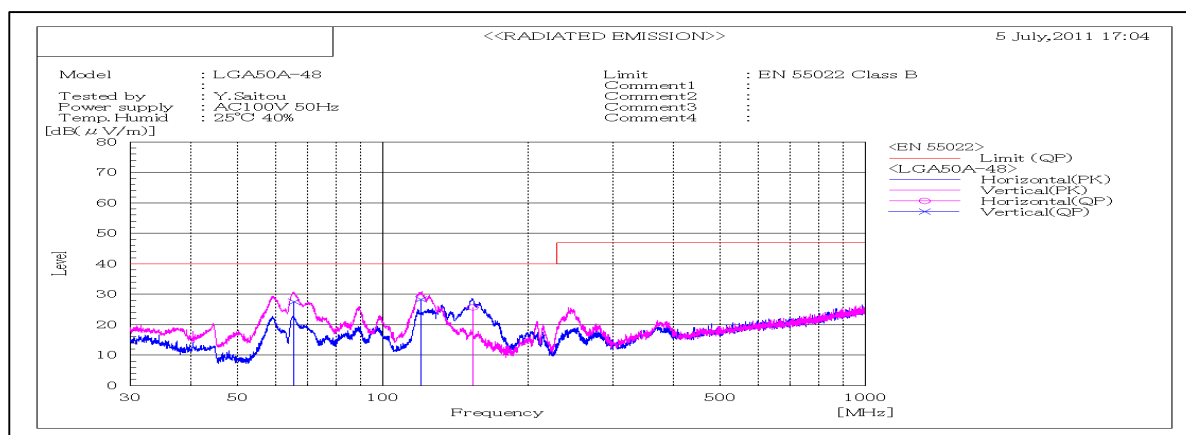


## DATA SHEET

Model		LGA50A-48	Date	05-Jul-11
Test		EMI Line conduction & Radiated emission	Temp.	25 degreeC
			Humid.	40 %RH
			Tested by	Y.Saitou



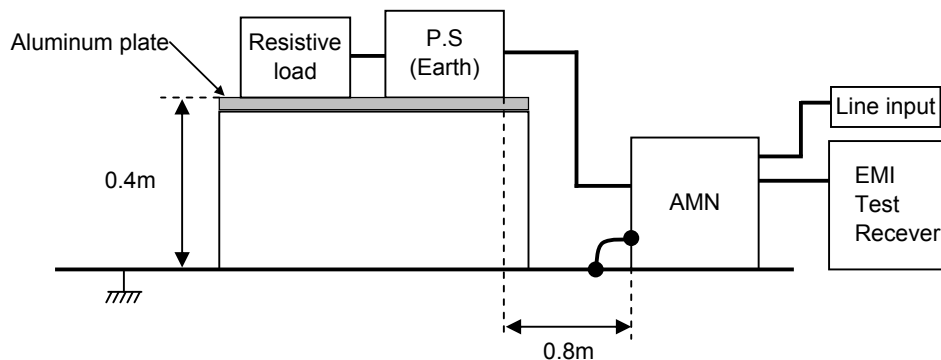
Frequency MHz	Harm	Line Phase	Reading dB(μV)		Factor dB	Level dB(μV)		Limit dB(μV)		Margin dB		Pass/ Fail	Remark
			QP	AV		QP	AV	QP	AV	QP	AV		
0.25937		VB	41.3	35.1	10.2	51.5	45.3	61.5	51.5	10	6.2	Pass	
0.26387		VA	38.8	32.6	10.2	49	42.8	61.3	51.3	12.3	8.5	Pass	
0.51911		VB	30.7	29.5	10.1	40.8	39.6	56	46	15.2	6.4	Pass	



Frequency MHz	Polarization	Reading dB(μV)		Space Loss dB	Level dB(mW)		Margin dB	Pass/ Fail	Height cm	Angle deg	Remark
		QP			QP	QP	QP				
65.503	V	49.8		-22.3	27.5		40	12.5	134	279	
119.94	V	44.4		-16.1	28.3		40	11.7	148	90	
153.693	H	42.2		-16.5	25.7		40	14.3	158	199	

DATA SHEET		Date	05-Jul-11
Model	Circuit used for measurement	Temp.	25 degreeC
Test	EMI Line conduction & Radiated emission	Humid.	40 %RH
		Tested by	Y.Saitou

## 1. Line conduction



## 2. Radiated emission

